Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/724,513	COHEN ET AL.	
Examiner	Art Unit	
Edna Wong	1795	

SEARCHED				
Class	Subclass	Date	Examiner	
205	118	5/22/2007	EW	
205	135	5/22/2007	EW	
205	666	5/22/2007	EW ·	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH I (INCLUDING SEAR)
	DATE	EXMR
Inventor Search	5/22/2007	EW
EAST	5/22/2007	EW
Search Updated	12/9/2007	EW